Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/047,629	MEYER, CONRAD K.
Examiner	Art Unit
Wen-Tai Lin	2154

	SEARCHED				
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Updated Search on BAST (See printant)	2/1/06	we	